



TO BE PERFORMED IN ADDITION TO THOSE APPLICABLE IN K1001

TESTS SHALL BE PERFORMED IN THE SPECIFIED ORDER, UNLESS OTHERWISE AGREED WITH THE INSPECTING AUTHORITY

TEST CONDITIONS -UNLESS OTHERWISE SPECIFIED												
		Vh (V)	Va (V)	Vg1 (V)	Vg2 (V)	Vg3 (V)	Vhk (V)					
		6.3	250	-3	100	0	0					
K1001	TEST	TEST CONDITIONS	AQL %	Insp. Level	Symbol	Limits						Units
						Min.	L.L.	Bogey	U.L.	Max.	ALD	
<b>GROUP A.</b>												
	Insulation	Vg1 - all = -100V Vg2 - all = -300V Va - all = -300V	100% 100% 100%	R R R	100 100 100					M Ω M Ω M Ω		
	Reverse Grid Current	Rg1 = 500 k max.	100%	Ig1					0.5	μA		
<b>GROUP B.</b>												
	Heater Current	Combined AQL	1.0									
	Heater - Cathode Leakage current	Vhk = ± 100V Vhk = 100V, Cath + Ve	0.65 0.65	II II	Ih Ihk	136	150		162	mA μA		
	Anode Current (1)		0.65	II	Ia	1.2			3.0	mA		
	Mutual Conductance		0.65	II	V2 gm	1.77 0.95	2.1 1.275	2.43 1.4	0.74 1.6	mA/V mA/V		
<b>GROUP C.</b>												
	Screen Grid Current		2.5	I	Ig2	0.2			0.8	mA		
	Anode Current (2)	Vg1 = -8V	2.5	I	Ia				140	μA		
	Change in Mutual Conductance	Vh = 5.7V Note 1	2.5	I	gm				15	%		
	Vibration Noise	Va(g) = 250V Vg(2) = 100V RL = 2k; Rk = 1.1k, Ck = 1000 μF	2.5	I	Va AC				2	mV rms		
<b>GROUP D</b>												
	Capacitances	Measured on a 1 Mc/s bridge with the valve mounted in a fully screened socket. No shield.	6.5	IC	Cag1 Cin Cout	3.0 2.75			0.01 5.5 5.25	pF pF pF		
	Hiss Output	Va(b) = Vg2 = 300V RL = 470 K Rg2 = 5.3 M Rk = 1.5k; Rg1 = 500k Cg = 50 μF; Cg2 = 0.1 μF Note 2.	6.5	IA	Va AC				1	mV rms		
	Grid Hum Output	As for Hiss Output Pin 4 earthed Amplifier bandwidth = 30-3000/s Rg1 = 500k	6.5	II	Va AC				4	mV rms		

## TESTS. (Contd.)

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K1001	TEST	TEST CONDITIONS	AQL %	Insp. Level	Symbol	Limits						Units
						Min.	LAL.	Bogey	UAL.	Max.	ALD	
	<u>GROUP D (Contd.)</u>											
	Cathode Hum	As for Grid Hum except $R_{g1} = 0$ , $C_k = 0$	6.5	IIA	Va AC					7.0		mV rms
	Reverse Grid Current	$V_h = 6.9V$ , $V_a = 330V$ $V_{g3} = 0$ , $V_{g2} = 135V$ $V_{g1}$ set to give $I_a$ $= 2.5 mA$ . Note 3	6.5	IIA						1.0		$\mu A$
7.1	Glass Strain	No voltages	6.5	I								
7.2	Base Strain	No voltages	6.5	IIA								
	<u>GROUP E</u>											
11.2	Resonance Search	As for Vibration Noise in Group C. Frequency range 25 - 500 c/s.		IC				record				
11.3	Fatigue	$V_h = 6.9$ switched 1 min ON, 3 mins OFF. $V_a = V_{g2} = 0$ Min peak accel. = 5g Frequency = 170 c/s Duration = 30, 39, 30 hrs.		IIA								
	<u>Post Fatigue Tests</u>	Combined AQL	6.5									
	Heater-Cathode Leakage Current	$V_{hk} = \pm 100V$	2.5		Ihk	-	-	-	-	20		$\mu A$
	Reverse Grid Current	$R_{g1} = 500 K$ max.	2.5		Ig1	-				1.5		$\mu A$
	Mutual Conductance		2.5		gm	.75				1.6		mA/V
	Vibration Noise	As in Group C.	2.5		Va AC					10		mV rms
11.4	Shock	Hammer angle = $30^\circ$ No voltages										
	<u>Post Shock Tests</u>											
	As for Post Fatigue Tests, above.											

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K1001	TEST	TEST CONDITIONS	AQL %	Insp. Level	Symbol	Limits						Units
						Min.	LAL.	Bogey	UAL.	Max.	ALD	
	<u>GROUP F</u>											
AVI/5	Life	Va = 250. Vhk = 170v rms Vg2 = 100. Vg3 = 0 Rk = 1.2k. Rg = 100k (nom)										
AVI/5.1	<u>Stability Life Test</u>											
	Change in Mutual Conductance.		1.0	I	μgm	-	-	-	-	15		%
AVI/5.3	<u>Intermittent Life Test</u>	see above		IA								
	<u>Life Test End-point 500 hrs.</u>	Combined AQL	6.5									
AVI/5.6	<u>Inoperatives</u>		2.5									
	Heater Current		2.5		Ih	138		150		162		mA
	Heater-Cathode Leakage Current	Vhk = ± 100V	2.5		Ihk	-	-	-	-	20		μA
	Reverse Grid Current	Rg1 = 500K max.	2.5		Igl	-	-	-	-	1.5		μA
	Mutual Conductance		2.5		gm	0.75	-	-	-	1.6		mA/V
	-dc- Average Change				Δ gm	-	-	-	-	15		%
	Insulation	As in Group A.	4.0		R	50	-	-	-	-		M
	<u>Life Test End-point 1000 hrs.</u>	Combined AQL	10	LI								
AVI/5.6	<u>Inoperatives</u>		4.0									
	Heater Current		2.5		Ih	138		150		162		mA
	Heater-Cathode Leakage Current	Vhk = ± 100V	4.0		Ihk	-	-	-	-	20		μA
	Reverse Grid Current	Rg1 = 500K max.	4.0		Igl	-	-	-	-	2.0		μA
	Mutual Conductance		4.0		gm	0.7	-	-	-	1.6		mA/V
	<u>GROUP G</u>											
AVI/2.5	Re-test after 28 holding period Inoperatives		0.5	100%								
AVI/5.6	Reverse Grid Current.	Rg1 = 500 k max.	0.5		Igl	-	-	-	-	0.5		μA

NOTES

1. The change in mutual conductance is expressed as:-

$$\frac{\text{gm at } 6.3V - \text{gm at } 5.7V}{\text{gm at } 6.3V} \times 100 \%$$

2. Noise output measured at anode of V.U.T. Amplifier band-width 30 c/s - 13 Kc/s (3 db points)

3. Ig, shall not be rising or out of limit after 10 minutes.

Amendment No. 1  
to Specification CV4006, Issue 1, dated 25th June, 1957

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Group D

Test Conditions

Hiss Output

Amend RG1 = 500K to read RG1 = 0

Grid Hum Output

Add RG1 = 500K

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N.24400;

T.V.C.  
for R.R.E.

✓ AAS